

# GaAs SPDT Switch DC - 4 GHz

# **MASW4030G**

V 2.00

#### **Features**

- Absorbtive or Reflective
- Excellent Intermodulation Products
- Excellent Temperature Stability
- Fast Switching Speed, 3 ns Typical
- Ultra Low DC Power Consumption
- Independent Bias Control

Guaran	–55°C to +85°C		
Frequenc	DC – 4.0 GHz		
Insertion	DC – 1.0 GHz DC – 2.0 GHz DC – 4.0 GHz	0.6 dB Max 0.8 dB Max 1.0 dB Max	
Isolation	DC - 1.0 GHz Absorbtive Mode DC - 2.0 GHz Reflective Mode DC - 2.0 GHz DC - 4.0 GHz	60 dB Min 50 dB Min 42 dB Min 40 dB Min	
VSWR	DC – 1.0 GHz DC – 2.0 GHz DC – 4.0 GHz	1.2:1 Max 1.2:1 Max 1.5:1 Max	

# **Operating Characteristics**

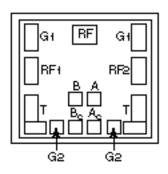
	50	Nominal	
Switching Characteristics tRISE, tFALL (10/90% or 90/10% RF) tON, tOFF (50% CTL to 90/10% RF) Transients (In-Band)			
oression** 0/–5 24 dBm 30 dBm		0/–8 dBm Typ dBm Typ	
Point up to +5 dBm) IP <sub>2</sub> 62 68		IP <sub>3</sub> dBm Typ dBm Typ	
	or 90/10% RF) to 90/10% RF) oression** 0/–5 24 dBm 30 dBm Point up to +5 dBm) IP <sub>2</sub> 62	or 90/10% RF) to 90/10% RF) 20  pression** 0/-5 24 dBm 25 30 dBm 33  Point up to +5 dBm) IP2 62 39	

### **Control Voltages (Complementary Logic)**

VINLow	Ū	`	0 to -0.	.2 V @ 9 μA Max
VINHi			−5 V @ 25 μA Typ to −8	V @ 0.75 µA Max

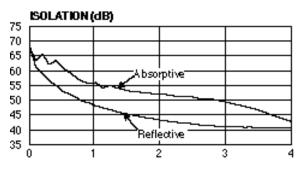
Die Size	0.043" x 0.041" x 0.010"
	(1.08mm x 1.03mm x 0.25mm)

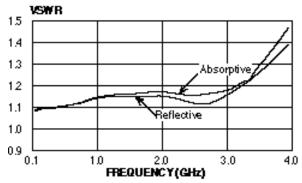
<sup>\*</sup> Previously MA4GM202MTC



# Typical Performance @ +25°C\*\*\*







<sup>\*\*</sup>All specifications apply with 50 impedance connected to all RF ports, and –5 Vdc control voltages.

<sup>\*\*\*</sup>Loss changes 0.0025 dB/°C

## **Handling Precautions**

Permanent damage to the MASW4030G may occur if the following precautions are not adhered to:

- A. Cleanliness The MASW4030G should be handled in a clean environment. DO NOT attempt to clean unit after the MASW4030G is installed.
- B. Static Sensitivity All chip handling equipment and personnel should be DC grounded.
- C. Transient Avoid instrument and power supply transients while bias is applied to the MASW4030G. Use shielded signal and bias cables to minimize inductive pick-up.
- D. Bias Apply voltage to either of the complementary control ports only when the other is grounded. No port should be allowed to "float".
- E. General Handling It is recommended that the MASW4030G chip be handled along the long side of the die with a sharp pair of bent tweezers. DO NOT touch the surface of the chip with fingers or tweezers.

## Mounting

The MASW4030G is back-metallized with Pd/Ni/Au(100/1,000/10,000Å) metallization. It can be diemounted with AuSn eutectic preforms or with thermally conductive epoxy. The package surface should be clean and flat before attachment.

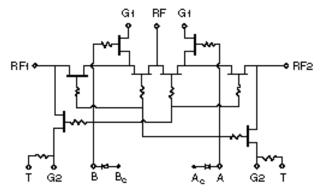
#### Eutectic Die Attach:

- A. A 80/20 gold/tin preform is recommended with a work surface temperature of approximately 255°C and a tool temperature of 265°C. When hot 90/10 nitrogen/hydrogen gas is applied, tool tip temperature should be approximately 290°C.
- B. DO NOT expose the MASW4030G to a temperature greater than 320°C for more than 20 seconds. No more than 3 seconds of scrubbing should be required for attachment.

#### Epoxy Die Attach:

- A. Apply a minimum amount of epoxy and place the MASW4030G into position. A thin epoxy fillet should be visible around the perimeter of the chip.
- B. Cure epoxy per manufacturer's recommended schedule.
- C. Electrically conductive epoxy may be used but is not required.

### **Schematic**



## Wire Bonding

- A. Ball or wedge with 1.0 mil diameter pure gold wire. Thermosonic wirebonding with a nominal stage temperature of 150°C and a ball bonding force of 40 to 50 grams or wedge bonding force of 18 to 22 grams is recommended. Ultrasonic energy and time should be adjusted to the minimum levels achieve reliable wirebonds.
- B. Wirebonds should be started on the chip and terminated on the package. GND bonds should be as short as possible; at least three and no more than four bond wires from ground pads to package are recommended.

Maximum Ratings				
A. Control Value (A or B):	-8.5 Vdc			
B. Max Input RF Power:	+34 dBm (500 MHz-4 GHz)			
C. Storage Temperature:	–65°C to +175°C			
D. Max Operating Temperature:	+175°C			

BondPad Dimensions — Inches (mm)					
	RF1, RF2	0.005 x 0.008 (0.125 x 0.200)			
	RFA1, RFB1	0.008 x 0.004 (0.200 x 0.100)			
	RFA2, RFB2	0.004 x 0.004 (0.100 x 0.100)			
	$A,B,A_C,B_C$	0.008 x 0.004 (0.200 x 0.100)			

#### **Truth Table**

				Control Inputs		Condition of BondPad	
Condition of Switch							
	Α	В	Т	G1	G2	RF1	RF2
Absorbtive	V <sub>IN</sub> Low	$V_{IN}H_{I}$	GND	GND	_	On	Off
SPDT	V <sub>IN</sub> Hı	$V_{IN}Low$	GND	GND	_	Off	On
Reflective	V <sub>IN</sub> Low	$V_{IN}H_{I}$	_	GND	GND	On	Off